SN65LVDS150





MuxIt[™] PLL FREQUENCY MULTIPLIER

FEATURES

		SN65LV	DS150
•	A Member of the MuxIt™ Serializer-	PW PAG	
	Deserializer Building-Block Chip Family	(Marked as (65LVDS150)
•	Pin Selectable Frequency Multiplier Ratios Between 4 and 40		28] NC
•	Input Clock Frequencies From 5 to 50 MHz		
•	Multiplied Clock Frequencies up to	CRI-[]3	26 NC
	400 MHz	V _T [] 4	25 Vcc
		GND 🛛 5	24 🛛 GND
•	Internal Loop Filters and Low PLL-Jitter of	M1 🛛 6	23 🛛 NC
	20 ps RMS Typical at 200 MHz	M2 🛛 7	22 GND
•	LVDS Compatible Differential Inputs and	M3 🛛 8	21 NC
	Outputs Meet or Exceed the Requirements of	M4 🚺 9	20 🛛 MCO+
	ANSI EIA/TIA-644-A	M5 🚺 10	19 🛛 MCO–
•	LVTTL Compatible Inputs Are 5 V Tolerant	BSEL [11	18 🛛 GND
•	LVDS Inputs and Outputs ESD Protection	GND [12	17 🛛 EN
	Exceeds 12 kV HBM	LCRO- [13	16 LCRO_EN
•	Operates From a Single 3.3 V Supply	LCRO+ [14	15 LVO
•	Packaged in 28-Pin Thin Shrink Small-Outline	NC – No internal	connection

DESCRIPTION

Package With 26 mil Terminal Pitch

The MuxIt is a family of general-purpose, multiple-chip building blocks for implementing parallel data serializers and deserializers. The system allows for wide parallel data to be transmitted through a reduced number of differential transmission lines over distances greater than can be achieved with a single-ended (e.g., LVTTL or LVCMOS) data interface. The number of bits multiplexed per transmission line is user selectable, allowing for higher transmission efficiencies than with other existing fixed ratio solutions. Muxlt utilizes the LVDS (TIA/EIA-644) low voltage differential signaling technology for communications between the data source and data destination.

The MuxIt family initially includes three devices supporting simplex communications; The SN65LVDS150 Phase Locked Loop-Frequency Multiplier, The SN65LVDS151 Serializer-Transmitter, and The SN65LVDS152 Receiver-Deserializer.

The SN65LVDS150 is a PLL based frequency multiplier designed for use with the other members of the MuxIt family of serializers and deserializers. The frequency multiplication ratio is pin selectable over a wide range of values from 4 through 40 to accommodate a broad spectrum of user needs. No external filter components are needed. A PLL lock indicator output is available which may be used to enable link data transfers.

The design of the SN65LVDS150 allows it to be used at either the transmit end or the receive end of the MuxIt serial link. The differential clock reference input (CRI) is driven by the system's parallel data clock when at the source end of the link, or by the link clock when at the destination end of the link. The differential clock reference input may be driven by either an LVDS differential signal, or by a single ended clock of either polarity. For single-ended use the nonclocked input is biased to the logic threshold voltage. A V_{CC}/2 threshold reference, VT, is provided on a pin adjacent the differential CRI pins for convenience when the input is used in a single-ended mode.



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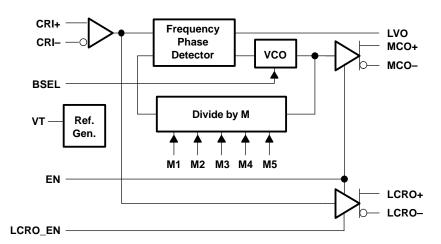


These devices have limited built-in ESD protection. The leads should be shorted together or the device placed in conductive foam during storage or handling to prevent electrostatic damage to the MOS gates.

DESCRIPTION (CONTINUED)

The multiplied clock output (MCO) is an LVDS differential signal used to drive the high-speed shift registers in either the SN65LVDS151 serializer-transmitter or the SN65LVDS152 receiver-deserializer. The link clock reference output (LCRO) is an LVDS differential signal provided to the SN65LVDS151 serializer-transmitter for transmission over the link.

An internal power on reset and an enable input (EN) control the operation of the SN65LVDS150. When V_{CC} is below 1.5 V, or when EN is low, the device is in a low power disabled state and the MCO and LCRO differential outputs are in a high-impedance state. When V_{CC} is above 3 V and EN is high, the device and the two differential outputs are enabled and operating to specifications. The link clock reference output enable input (LCRO_EN) is used to turn off the LCRO output when it is not being used. A band select input (BSEL) is used to optimize the VCO performance as a function of M-clock frequencies and M multiplier that is being used: The f_{max} parameter in the switching characteristic table includes details on the MCO frequency and choices of BSEL and M.



BLOCK DIAGRAM

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Frequency Multiplier Value Table⁽¹⁾

	M1	M2	M3	M4	М5	RECOMME (MI	
(m)						BSEL = 0	BSEL = 1
4	L	L	L	L	L	f _{IN} < 12.50	$12.50 \le f_{IN}$
Reserved	L	L	L	L	н	NA	NA
6	L	L	L	н	L	f _{IN} < 8.33	$8.33 \leq f_{IN}$
Reserved	L	L	L	н	н	NA	NA
8	L	L	Н	L	L	f _{IN} < 12.50	$12.50 \le f_{IN}$
9	L	L	Н	L	Н	f _{IN} < 11.11	11.11 ≤ f _{IN}
10	L	L	Н	Н	L	f _{IN} < 10.00	$10.00 \le f_{IN}$
Reserved	L	L	Н	Н	Н	NA	NA
12	L	Н	L	L	L	f _{IN} < 8.3	$8.3 \leq f_{IN}$
13	L	Н	L	L	Н	f _{IN} < 7.7	$7.7 \le f_{IN}$
14	L	Н	L	Н	L	f _{IN} < 7.14	$7.14 \leq f_{IN}$
15	L	Н	L	Н	Н	f _{IN} < 6.67	$6.67 \le f_{IN}$
16	L	Н	Н	L	L	f _{IN} < 6.25	$6.25 \le f_{IN}$
17	L	Н	Н	L	Н	f _{IN} < 5.88	$5.88 \leq f_{IN}$
18	L	Н	Н	Н	L	f _{IN} < 5.56	$5.56 \le f_{IN}$
19	L	Н	Н	Н	Н	f _{IN} < 5.26	$5.26 \le f_{IN}$
20	Н	L	L	L	L	f _{IN} = 5.00	$5.00 \le f_{IN}$
22	Н	L	L	L	Н	NA	$5.00 \le f_{IN}$
24	Н	L	L	Н	L	NA	$5.00 \le f_{IN}$
26	Н	L	L	Н	Н	NA	$5.00 \le f_{IN}$
28	Н	L	Н	L	L	NA	$5.00 \leq f_{IN}$
30	Н	L	Н	L	Н	NA	$5.00 \le f_{IN}$
32	Н	L	Н	Н	L	NA	$5.00 \le f_{IN}$
34	Н	L	Н	Н	Н	NA	$5.00 \le f_{IN}$
36	Н	Н	L	L	L	NA	$5.00 \le f_{IN}$
38	Н	Н	L	L	Н	NA	$5.00 \le f_{IN}$
40	Н	Н	L	Н	L	NA	$5.00 \le f_{IN}$
Reserved	Н	Н	L	Н	Н	NA	NA
Reserved	Н	Н	Н	L	L	NA	NA
Reserved	Н	Н	Н	L	н	NA	NA
Reserved	Н	Н	Н	Н	L	NA	NA
Reserved	Н	Н	Н	Н	н	NA	NA

(1) H = high level, L= low level

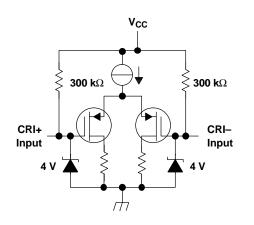


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SLLS443-DECEMBER 2000

EQUIVALENT INPUT AND OUTPUT SCHEMATIC DIAGRAMS

V_{CC}



300 kΩ ≥

400 Ω

⇒300 kΩ

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Mn, EN, Only

'6 V

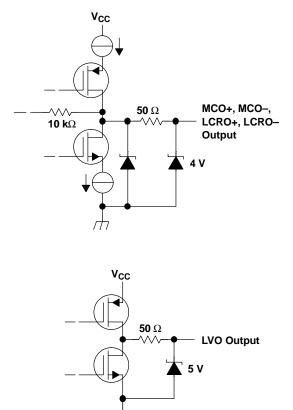
BSEL,

LCRO_EN Only

M1-M5,

EN Input

LCRO_EN, BSEL, or



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SN65LVDS150

SLLS443-DECEMBER 2000

Terminal Functions

TERMIN	TERMINAL		RMINAL		TYPE	DECODIDITION
NAME	NO.	I/O	TYPE	DESCRIPTION		
BSEL	11	I	LVTTL	Band select. Used to optimize VCO performance for minimum M-clock jitter: See recommended f_{max} in the frequency multiplier value table.		
CRI+, CRI–	2, 3	I	LVDS	Clock reference input. This is the reference clock signal for the PLL frequency multiplier.		
EN	17	I	LVTTL	Enable input. Used to disable the device to a low power state. A high level input enables to device, a low level input disables the device.		
GND	5, 12, 18, 22, 24	I	NA	Circuit ground		
LCRO–, LCRO+	13, 14	0	LVDS	Link clock reference output. This is the data block synchronization clock signal from the PLL frequency multiplier.		
LCRO_EN	16	I	LVTTL	LCRO enable. Used to turn off the LCRO outputs when they are not used. A high level input enables the LCRO output; a low level input disables the LCRO output.		
LVO	15	0	LVTTL	Lock/valid output. This is signal required for proper MuxIt system operation. It is to be directly connected to the LVI inputs of SN65LVDS151 or SN65LVDS152 devices. It is used to inhibit the operation of those devices until after the PLL has stabilized. It remains at a low level following a reset until the PLL has become phase locked. A low to high-level transition indicates phase lock has occurred.		
M1-M5	6–10	I	LVTTL	Multiplier value selection inputs. These inputs determine the frequency multiplication ratio M.		
MCO-, MCO+	19, 20	0	LVDS	M-clock output. This is the high frequency multiplied clock output from the PLL frequency multiplier. It is used by the companion serializer or deserializer devices to synchronizes the transmission or reception of data		
NC	21, 23, 26–28		NA	These pins are not connected and may be left open.		
V _{CC}	1, 25		NA	Supply voltage		
V _T	4		NA	Voltage reference. A $V_{CC}\!/2$ reference supplied for the unused CRI input when operated in a single-ended mode.		

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)⁽¹⁾

			UNIT
V_{CC}	Supply voltage range ⁽²⁾		–0.5 V to 4 V
		EN, BSEL, LCRO_EN, or M1-M5 inputs	–0.5 V to 6 V
	Voltage range	CRI input	–0.5 V to 4 V
		LCRO±, MCO± outputs	–0.5 V to 4 V
		Human body model (CRI±, LCRO±, MCO±,and GND ⁽³⁾	±12 kV
	Electrostatic discharge	All pins	±2 kV
		Charged-device model (all pins) ⁽⁴⁾	±500 V
	Continuous total power of	lissipation	See Dissipation Rating Table
T _{stg}	Storage temperature range		–65°C to 150°C
	Lead temperature 1,6 mr	n (1/16 inch) from case for 10 seconds	260°C

(1) Stresses beyond those listed under absolute maximum ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under recommended operating conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) All voltages, except differential I/O bus voltages, are with respect to the network ground terminal.

(3) Tested in accordance with JEDEC Standard 22, Test method A114-B.

(4) Tested in accordance with JEDEC Standard 22, Test method C101.



DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C	DERATING FACTOR ⁽¹⁾	T _A = 85°C
	POWER RATING	ABOVE T _A = 25°C	POWER RATING
PW	1207 mW	9.6 mW/°C	628 mW

(1) This is the inverse of the junction-to-ambient thermal resistance when board-mounted and with no air flow.

RECOMMENDED OPERATING CONDITIONS

			MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage		3	3.3	3.6	V
VIH	High-level input voltage	EN, BSEL, LCRO_EN, M1–M5	2			V
V _{IL}	Low-level input voltage	EN, BSEL, LORO_EN, MIT-MIS			0.8	V
$ V_{ID} $	Magnitude of differential input voltage	CRI	0.1		0.6	V
V _{IC}	Common-mode input voltage	CRI	$\frac{ V_{ID} }{2}$	2	$\frac{2.4 - \frac{ V_{\text{ID}} }{2}}{V_{\text{CC}} - 0.8}$	V
T _A	Operating free-air temperature		40		85	°C

TIMING REQUIREMENTS

		MIN	ΤΥΡ ΜΑΧ	UNIT
t _{c(1)}	Input clock cycle time	20	200	ns
t _{w(1)}	High-level input clock pulse width duration	0.4 t _{c(1)}	0.6 t _{c(1)}	
f _(clock)	Input clock frequency, CRI	5	50	MHz

ELECTRICAL CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
V _{IT+}	Positive-going differential input	t threshold voltage	One Figure 4 and Table 4			100	mV
V _{IT-}	Negative-going differential inp	ut threshold voltage	See Figure 1 and Table 1	-100			mV
V _{OD(SS)}	Steady-state differential output	t voltage magnitude	$R_L = 100 \Omega$, See Figure 3	247	340	454	mV
$\Delta V_{OD(SS)} $	Change in steady-state differe magnitude between logic state		$V_{ID} = \pm 100 \text{ mV},$ See Figure 2 and Figure 3	-50		50	mV
V _{OC(SS)}	Steady-state common-mode of	utput voltage		1.125		1.375	V
$\Delta V_{OC(SS)}$	Change in steady-state comm voltage between logic states	on-mode output	See Figure 4	-50		50	mV
V _{OC(PP)}	Peak-to-peak change commo	n-mode output voltage			50	150	mV
V _{OH}	High-level output voltage (LVO)		$I_{OH} = -8 \text{ mA}$	2.4			V
V _{OL}	Low-level output voltage (LVC))	I _{OL} = 8 mA			0.4	V
V _(T)	Threshold reference bias volta	ge	−100 μA ≤ I _O ≤ 100 μA	$\frac{V_{CC}}{2} - 0.15$		$\frac{V_{CC}}{2} + 0.15$	V
1	Supply current		Enabled, $R_L = 100 \Omega$, CRI ± open		25	70	mA
Icc	Supply current		Disabled		2.5	6	IIIA
	Input current (CRI inputs)		V ₁ = 0	-20		-2	
li -	input current (CRT inputs)		V _I = 2.4 V	-1.2			μA
I _(ID)	Differential input current (IIA -	IB) (CRI inputs)	$V_{IC} = 0.05 \text{ V or } 2.35 \text{ V}, V_{ID} = \pm 0.1 \text{ V}$	-2		2	μA
I _{I(OFF)}	Power-off input current (CRI in	nputs)	$V_{CC} = 0 V, V_I = 3.6 V$			20	μA
	Lligh lovel input ourrent	M1-M5, EN	N 2.V			20	
IIH	High-level input current	BSEL, LCRO_EN	$V_{IH} = 2 V$	-10			μA
	Low lovel input ourrent	M1-M5, EN	V 0.9.V			10	
IIL	Low-level input current	BSEL, LCRO_EN	- V _{IL} = 0.8 V	-20			μA
1	Chart aircuit autout aurrant		$V_{O+} \text{ or } = V_{O-} = 0 \text{ V}$	-10		10	
l _{os}	Short-circuit output current	MCO, LCRO	V _{OD} = 0 V	-10		10	mA
l _{oz}	High-impedance output current	MCO, LCRO	$V_{O} = 0 V \text{ or } V_{CC}$	-5		5	μA
I _{O(OFF)}	Power-off output current		$V_{CC} = 1.5 \text{ V}$, $V_O = 3.6 \text{ V}$	-5		5	μA
CI	Input capacitance (CRI inputs)	V _{ID} = [(0.4sin(4E6πt) = 0.5] V		3		pF

(1) All typical values are at T_A = 25°C and with V_{CC} = 3.3 V.

SWITCHING CHARACTERISTICS

over recommended operating conditions (unless otherwise noted)

	PARAMETER		TEST CONDITIONS	MIN	TYP ⁽¹⁾	MAX	UNIT
	MCO output clock period jitter ⁽²⁾ $p-p$ EN = 1, BSEL = 1,			200		20	
		rms	$LCRO_EN = 1, M = 40,$		20		ps
t _(lock)	Lock (stabilization time) ⁽³⁾		$f_1 = 5 MHz$		0.2	1	ms
t _{w(2)}	Multiplied clock output pulse widt	h		0.4t _{c(2)}		0.6t _{c(2)}	
t _r	Differential output signal rise time	e (MCO, LCRO)	$R_L = 100 \Omega$, C _L = 10 pF, See Figure 5	0.3	0.6	1.5	20
t _f	Differential output signal fall time	(MCO, LCRO)		0.3	0.6	1.5	ns
		f _I = 5 MHz, M = 4		-2.5	0	2.5	
t _(OS)	CRI↑ to MCO↑ offset time	f _I = 10 MHz, M = 10	$R_L = 100 \Omega$, C _L = 10 pF, See Figure 6	-1.5	0	1.5	
		f _I = 5 MHz, M = 40		-1.65	0	1.65	
		f _I = 5 MHz, M = 4		0.5	2.5	6	
t _d	MCO↑ before LCRO↑ , time delay	f _I = 10 MHz, M = 10	R _L = 100 Ω, C _L = 10 pF, See Figure 6	0.5	2.5	6	ns
	dolay	f _I = 5 MHz, M = 40		0.5	2.5	4.5	
			BSEL =1, M = 4, 6	200			
£	Maximum MCO output frequency		BSEL =1, M ≠ 4, 6	400			
f _{max}			BSEL =0, M = 4, 6	50			MHz
			BSEL =0, M ≠ 4, 6	100			

(1) All typical values are at $T_A = 25^{\circ}$ C and with $V_{CC} = 3.3$ V. (2) Output clock jitter is the change in the output clock period from one cycle to the next cycle observed over 10,000 cycles with a source having less than 10 psec jitter rms. Lock time is measured from the application of the clock reference input signal to the assertion of a high-level lock/valid output.

(3)

PARAMETER MEASUREMENT INFORMATION

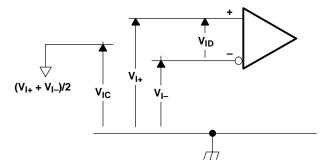
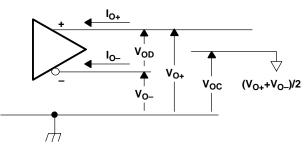


Figure 1. Receiver Input Voltage Definitions

	OLTAGES	RESULTING DIFFERENTIAL INPUT VOLTAGE	RESULTING COMMON- MODE INPUT VOLTAGE
V _(IA)	V _(IB)	V _{ID}	V _{IC}
1.25 V	1.15 V	100 mV	1.2 V
1.15 V	1.25 V	–100 mV	1.2 V
2.4 V	2.3 V	100 mV	2.35 V
2.3 V	2.4 V	–100 mV	2.35 V
0.1 V	0 V	100 mV	0.05 V
0 V	0.1 V	–100 mV	0.05 V
1.5 V	0.9 V	600 mV	1.2 V
0.9 V	1.5 V	–600 mV	1.2 V
2.4 V	1.8 V	600 mV	2.1 V
1.8 V	2.4 V	–600 mV	2.1 V
0.6 V	0 V	600 mV	0.3 V
0 V	0.6 V	–600 mV	0.3 V





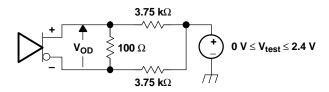
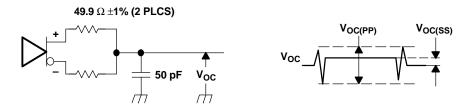
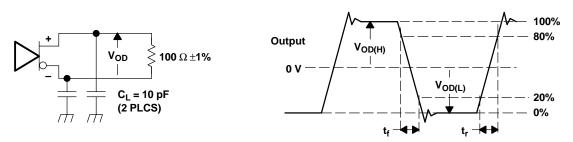


Figure 3. V_{OD} Test Circuit



A. All input pulses are supplied by a generator having the following characteristics: t_r or $t_f \le 1$ ns, pulse repetition rate (PRR) = 0.5 Mpps, Pulse width = 500 ± 10 ns . C_L includes instrumentation and fixture capacitance within 0,06 m of the D.U.T. The measurement of $V_{OC(PP)}$ is made on test equipment with a -3 dB bandwidth of at least 5 GHz.

Figure 4. Test Circuit and Definitions for the Driver Common-Mode Output Voltage



A. All input pulses are supplied by a generator having the following characteristics: t_r or $t_r \le 1$ ns, pulse repetition rate (PRR) = 50 Mpps, Pulse width = 10 ± 0.2 ns . C_L includes instrumentation and fixture capacitance within 0,06 m of the D.U.T.

Figure 5. Test Circuit, Timing, and Voltage Definitions for the Differential Output Signal

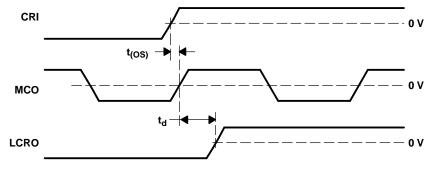
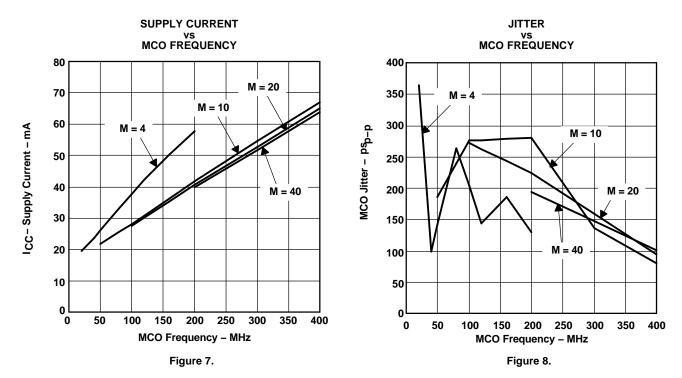


Figure 6. Output Timing Waveform Definitions

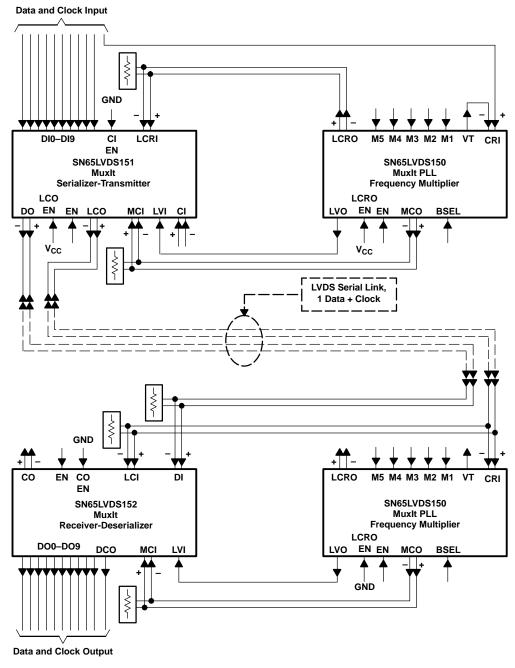
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS (continued)

BASIC APPLICATIONS EXAMPLES

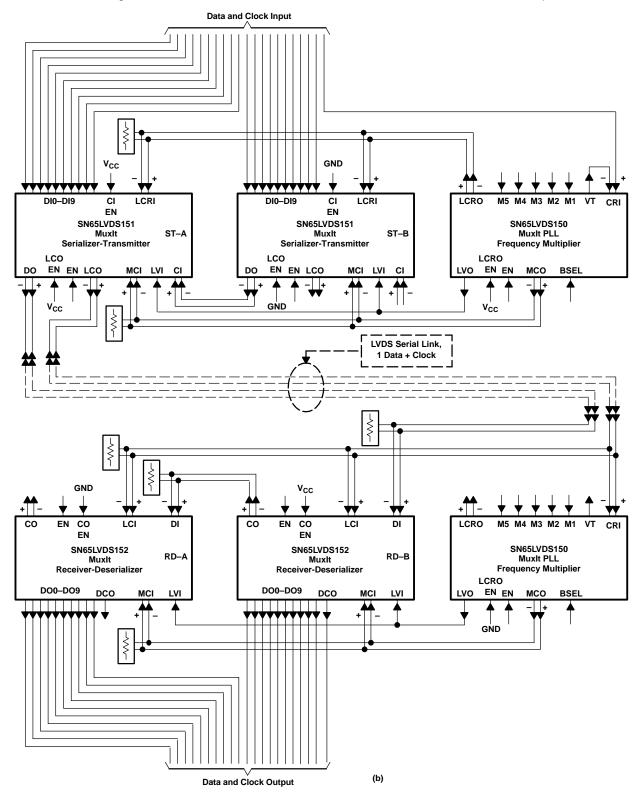
Parallel data path width between 4 and 10 bits, only one LVDS data link required.



(a)

TYPICAL CHARACTERISTICS (continued)

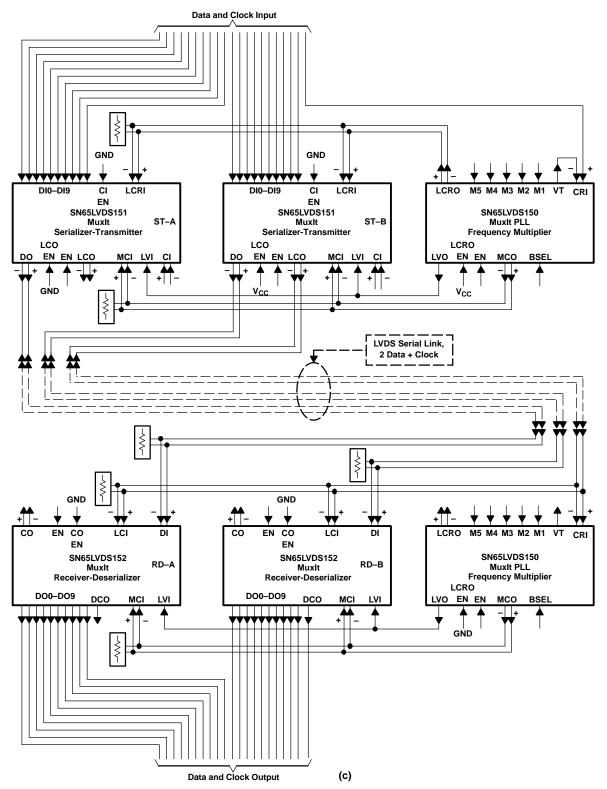
Parallel data path width between 11 and 20 bits, aggregate data rate low enough to allow transmission over one LVDS data link, sharing of PLL-FM between serializer-transmitter and receiver-deserializer chips at each end.





TYPICAL CHARACTERISTICS (continued)

Parallel data path width between 11 and 20 bits, aggregate data rate requires transmission over two separate LVDS data links, sharing of PLL-FM between serializer-transceiver and receiver-deserializer chips at each end.





PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
SN65LVDS150PW	ACTIVE	TSSOP	PW	28	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LVDS150	Samples
SN65LVDS150PWG4	ACTIVE	TSSOP	PW	28	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LVDS150	Samples
SN65LVDS150PWR	ACTIVE	TSSOP	PW	28	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	65LVDS150	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

10-Dec-2020

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PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



1	All dimensions are nominal												
	Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
	SN65LVDS150PWR	TSSOP	PW	28	2000	330.0	16.4	6.9	10.2	1.8	12.0	16.0	Q1



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PACKAGE MATERIALS INFORMATION

5-Jan-2022



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
SN65LVDS150PWR	TSSOP	PW	28	2000	350.0	350.0	43.0	



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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	Τ (μm)	B (mm)
SN65LVDS150PW	PW	TSSOP	28	50	530	10.2	3600	3.5
SN65LVDS150PWG4	PW	TSSOP	28	50	530	10.2	3600	3.5

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